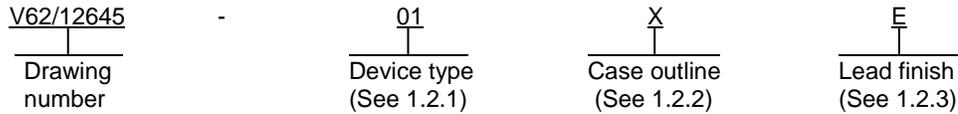


1. SCOPE

1.1 Scope. This drawing documents the general requirements of a high performance 14 bit, 8 channel 250 kilo symbols per second (kSPS) successive approximation register (SAR) analog to digital converter (ADC) microcircuit, with an operating temperature range of -55°C to +125°C.

1.2 Vendor Item Drawing Administrative Control Number. The manufacturer's PIN is the item of identification. The vendor item drawing establishes an administrative control number for identifying the item on the engineering documentation:



1.2.1 Device type(s).

<u>Device type</u>	<u>Generic</u>	<u>Circuit function</u>
01	AD7949	14 bit, 8 channel 250 kSPS successive approximation register (SAR) analog to digital converter

1.2.2 Case outline(s). The case outline(s) are as specified herein.

<u>Outline letter</u>	<u>Number of pins</u>	<u>JEDEC PUB 95</u>	<u>Package style</u>
X	20	MO-220-VGGD-1	Lead frame chip scale quad package

1.2.3 Lead finishes. The lead finishes are as specified below or other lead finishes as provided by the device manufacturer:

<u>Finish designator</u>	<u>Material</u>
A	Hot solder dip
B	Tin-lead plate
C	Gold plate
D	Palladium
E	Gold flash palladium
Z	Other

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1.3 Absolute maximum ratings. 1/

Analog inputs (IN _x) and common channel inputs (COM _x)	GND – 0.3 V to V _{DD} + 0.3 V or V _{DD} ± 130 mA
Reference input/output (REF)	GND – 0.3 V to V _{DD} + 0.3 V
Internal reference output / reference buffer input (REFIN)	GND – 0.3 V to V _{DD} + 0.3 V
Supply voltages:	
Power supply (V _{DD}) and input/output interface digital power (V _{IO}) to GND	-0.3 V to +7 V
V _{IO} to V _{DD}	-0.3 V to V _{DD} + 0.3 V
Data input (DIN), convert input (CNV), serial data clock input (SCK) to GND	-0.3 V to V _{IO} + 0.3 V
Serial data output (SDO) to GND	-0.3 V to V _{IO} + 0.3 V
Junction temperature range (T _J)	150°C
Storage temperature range (T _{STG})	-65°C to +150°C
Thermal impedance, junction to case(θ _{JC})	4.4°C/W
Thermal impedance, junction to ambient (θ _{JA})	47.6°C/W

1.4 Recommended operating conditions. 2/

Operating free-air temperature range (T _A)	-55°C to +125°C
--	-----------------

- 1/ Stresses beyond those listed under “absolute maximum rating” may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under “recommended operating conditions” is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.
- 2/ Use of this product beyond the manufacturers design rules or stated parameters is done at the user’s risk. The manufacturer and/or distributor maintain no responsibility or liability for product used beyond the stated limits.

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2. APPLICABLE DOCUMENTS

JEDEC PUB 95 – Registered and Standard Outlines for Semiconductor Devices

(Applications for copies should be addressed to the Electronic Industries Alliance, 2500 Wilson Boulevard, Arlington, VA 22201-3834 or online at <http://www.jedec.org>)

3. REQUIREMENTS

3.1 Marking. Parts shall be permanently and legibly marked with the manufacturer’s part number as shown in 6.3 herein and as follows:

- A. Manufacturer’s name, CAGE code, or logo
- B. Pin 1 identifier
- C. ESDS identification (optional)

3.2 Unit container. The unit container shall be marked with the manufacturer’s part number and with items A and C (if applicable) above.

3.3 Electrical characteristics. The maximum and recommended operating conditions and electrical performance characteristics are as specified in 1.3, 1.4, and table I herein.

3.4 Design, construction, and physical dimension. The design, construction, and physical dimensions are as specified herein.

3.5 Diagrams.

3.5.1 Case outline. The case outline shall be as shown in 1.2.2 and figure 1.

3.5.2 Terminal connections. The terminal connections shall be as shown in figure 2.

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TABLE I. Electrical performance characteristics. 1/

Test	Symbol	Conditions $V_{DD} = 2.3 \text{ V to } 5.5 \text{ V}$, $V_{IO} = 1.8 \text{ V to } V_{DD}$, $V_{REF} = V_{DD}$, unless otherwise specified	Temperature, T_A	Device type	Limits		Unit
					Min	Max	
Resolution			-55°C to +125°C	01	14		Bits
Analog input.							
Voltage range		Unipolar mode	-55°C to +125°C	01	0	+V _{REF}	V
		Bipolar mode			$-\frac{V_{REF}}{2}$	$+\frac{V_{REF}}{2}$	
Absolute input voltage		Positive input, unipolar and bipolar modes	-55°C to +125°C	01	-0.1	V _{REF} + 0.1	V
		Negative or COM input, unipolar mode			-0.1	+0.1	
		Negative or COM input, bipolar mode			$\frac{V_{REF}}{2} - 0.1$	$\frac{V_{REF}}{2} + 0.1$	
Analog input CMRR		f _{IN} = 250 kHz	-55°C to +125°C	01	68 typical		dB
Leakage current	I _{LK}	Acquisition phase	+25°C	01	1 typical		nA
Throughput							
Conversion rate							
Full bandwidth <u>2/</u>	FBW	V _{DD} = 4.5 V to 5.5 V	-55°C to +125°C	01	0	250	kSPS
		V _{DD} = 2.3 V to 4.5 V			0	200	
1/4 bandwidth <u>2/</u>		V _{DD} = 4.5 V to 5.5 V	-55°C to +125°C	01	0	62.5	kSPS
		V _{DD} = 2.3 V to 4.5 V			0	50	
Transient response		Full scale step, full bandwidth	-55°C to +125°C	01		1.8	μs
		Full scale step, 1/4 bandwidth				14.5	
Accuracy							
No missing codes	NMC		-55°C to +125°C	01	14		Bits
Integral linearity error	ILE		-55°C to +125°C	01	-1	+1	LSB <u>3/</u>
Differential linearity error	DLE		-55°C to +125°C	01	-1	+1	LSB
Transition noise	NT	REF = V _{DD} = 5 V	+25°C	01	0.1 typical		LSB

See footnotes at end of table.

DLA LAND AND MARITIME COLUMBUS, OHIO	SIZE A	CODE IDENT NO. 16236	DWG NO. V62/12645
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TABLE I. Electrical performance characteristics – Continued. 1/

Test	Symbol	Conditions $V_{DD} = 2.3 \text{ V to } 5.5 \text{ V},$ $V_{IO} = 1.8 \text{ V to } V_{DD},$ $V_{REF} = V_{DD},$ unless otherwise specified	Temperature, T_A	Device type	Limits		Unit
					Min	Max	
Accuracy – continued.							
Gain error <u>4/</u>	AE		-55°C to +125°C	01	-5	+5	LSB
Gain error match	AEM		-55°C to +125°C	01	-1	+1	LSB
Gain error temperature drift	$\Delta AE/\Delta T$		-55°C to +125°C	01	±1 typical		ppm/ °C
Offset error <u>4/</u>	OE		-55°C to +125°C	01	±0.5 typical		LSB
Offset error match	OEM		-55°C to +125°C	01	-1	+1	LSB
Offset error temperature drift	$\Delta OE/\Delta T$		-55°C to +125°C	01	±1 typical		ppm/ °C
Power supply sensitivity	PSS	$V_{DD} = 5 \text{ V} \pm 5\%$	-55°C to +125°C	01	±0.2 typical		LSB
AC Accuracy <u>5/</u>							
Dynamic range	DR		-55°C to +125°C	01	85.6 typical		dB <u>6/</u>
Signal to noise	SN	$f_{IN} = 20 \text{ kHz}, V_{REF} = 5 \text{ V}$	-55°C to +125°C	01	84.5		dB
		$f_{IN} = 20 \text{ kHz},$ $V_{REF} = 4.096 \text{ V internal REF}$			85 typical		
		$f_{IN} = 20 \text{ kHz},$ $V_{REF} = 2.5 \text{ V internal REF}$			84 typical		
Signal to noise and distortion	SINAD	$f_{IN} = 20 \text{ kHz}, V_{REF} = 5 \text{ V}$	-55°C to +125°C	01	84		dB
		$f_{IN} = 20 \text{ kHz},$ $V_{REF} = 5 \text{ V}, -60 \text{ dB input}$			33.5 typical		
		$f_{IN} = 20 \text{ kHz},$ $V_{REF} = 4.096 \text{ V internal REF}$			85 typical		
		$f_{IN} = 20 \text{ kHz},$ $V_{REF} = 2.5 \text{ V internal REF}$			84 typical		

See footnotes at end of table.

DLA LAND AND MARITIME COLUMBUS, OHIO	SIZE A	CODE IDENT NO. 16236	DWG NO. V62/12645
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TABLE I. Electrical performance characteristics – Continued. 1/

Test	Symbol	Conditions $V_{DD} = 2.3 \text{ V to } 5.5 \text{ V}$, $V_{IO} = 1.8 \text{ V to } V_{DD}$, $V_{REF} = V_{DD}$, unless otherwise specified	Temperature, T_A	Device type	Limits		Unit
					Min	Max	
AC Accuracy – continued. 5/							
Total harmonic distortion	THD	$f_{IN} = 20 \text{ kHz}$	-55°C to +125°C	01	-100 typical		dB
Spurious free dynamic range	SFDR	$f_{IN} = 20 \text{ kHz}$	-55°C to +125°C	01	108 typical		dB
Channel to channel crosstalk	CCCT	$f_{IN} = 100 \text{ kHz}$ on adjacent channel(s)	-55°C to +125°C	01	-125 typical		dB
Sampling dynamics							
-3 dB input bandwidth		Full bandwidth	-55°C to +125°C	01	1.7 typical		MHz
		1/4 bandwidth			0.425 typical		
Aperature delay		$V_{DD} = 5 \text{ V}$	-55°C to +125°C	01	2.5 typical		ns
Internal reference							
REF output voltage		2.5 V	+25°C	01	2.490	2.510	V
		4.096 V			4.086	4.106	
REFIN output voltage 7/		2.5 V	+25°C	01	1.2 typical		V
		4.096 V			2.3 typical		
REF output current			-55°C to +125°C	01	±300 typical		µA
Temperature drift			-55°C to +125°C	01	±10 typical		ppm/°C
Line regulation	V_{RLINE}	$V_{DD} = 5 \text{ V} \pm 5\%$	-55°C to +125°C	01	±15 typical		ppm/V
Long term drift		1000 hours	-55°C to +125°C	01	50 typical		ppm
Turn on settling time	t_{ON}	$C_{REF} = 10 \text{ } \mu\text{F}$	-55°C to +125°C	01	5 typical		ms
External reference							
Voltage reference		REF input	-55°C to +125°C	01	0.5	$V_{DD} + 0.3$	V
		REFIN input (buffered)			0.5	$V_{DD} - 0.5$	
Current drain		250 kSPS, REF = 5 V	-55°C to +125°C	01	50 typical		µA

See footnotes at end of table.

DLA LAND AND MARITIME COLUMBUS, OHIO	SIZE A	CODE IDENT NO. 16236	DWG NO. V62/12645
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TABLE I. Electrical performance characteristics – Continued. 1/

Test	Symbol	Conditions $V_{DD} = 2.3 \text{ V to } 5.5 \text{ V,}$ $V_{IO} = 1.8 \text{ V to } V_{DD,}$ $V_{REF} = V_{DD,}$ unless otherwise specified	Temperature, T_A	Device type	Limits		Unit
					Min	Max	
Temperature sensor							
Output voltage <u>8/</u>	V_{OUT}		+25°C	01	283 typical		mV
Temperature sensitivity			-55°C to +125°C	01	1 typical		mV/ °C
Digital inputs							
Input low voltage	V_{IL}		-55°C to +125°C	01	-0.3	+0.3 x V_{IO}	V
Input high voltage	V_{IH}		-55°C to +125°C	01	0.7 x V_{IO}	$V_{IO} +$ 0.3	V
Input low current	I_{IL}		-55°C to +125°C	01	-1	+1	µA
Input high current	I_{IH}		-55°C to +125°C	01	-1	+1	µA
Digital outputs							
Data format <u>9/</u>							
Pipeline delay <u>10/</u>							
Output low voltage	V_{OL}	$I_{SINK} = +500 \mu\text{A}$	-55°C to +125°C	01		0.4	V
Output high voltage	V_{OH}	$I_{SOURCE} = -500 \mu\text{A}$	-55°C to +125°C	01	$V_{IO} - 3$		V
Power supplies							
Power supply voltage	V_{DD}	Specified performance	-55°C to +125°C	01	2.3	5.5	V
Input/output interface digital power	V_{IO}	Specified performance	-55°C to +125°C	01	2.3	$V_{DD} +$ 0.3	V
		Operating range			1.8	$V_{DD} +$ 0.3	
Standby current <u>11/ 12/</u>	I_{SB}	V_{DD} and $V_{IO} = 5 \text{ V}$	+25°C	01	50 typical		nA

See footnotes at end of table.

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TABLE I. Electrical performance characteristics – Continued. 1/

Test	Symbol	Conditions V _{DD} = 2.3 V to 5.5 V, V _{IO} = 1.8 V to V _{DD} , V _{REF} = V _{DD} , unless otherwise specified	Temperature, T _A	Device type	Limits		Unit
					Min	Max	
Power supplies – continued.							
Power dissipation	PD	V _{DD} = 2.5 V, 100 SPS throughput	-55°C to +125°C	01	1.5 typical		μW
		V _{DD} = 2.5 V, 100 kSPS throughput				2.0	mW
		V _{DD} = 2.5 V, 200 kSPS throughput				4.0	
		V _{DD} = 5 V, 250 kSPS throughput				12.5	
		V _{DD} = 5 V, 250 kSPS throughput with internal reference				15.5	
Energy conversion			-55°C to +125°C	01	50 typical		nJ
Temperature range specified performance				01	-55	+125	°C

See footnotes at end of table.

DLA LAND AND MARITIME COLUMBUS, OHIO	SIZE A	CODE IDENT NO. 16236	DWG NO. V62/12645
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TABLE I. Electrical performance characteristics – Continued. 1/

Test	Symbol	Conditions $V_{DD} = 4.5\text{ V to }5.5\text{ V}$, $V_{IO} = 1.8\text{ V to }V_{DD}$, see figures 3 and 4 unless otherwise specified	Temperature, T_A	Device type	Limits		Unit
					Min	Max	
Conversion time: CNV rising edge to data available	t_{CONV}		-55°C to +125°C	01		2.2	μs
Acquisition time	t_{ACQ}		-55°C to +125°C	01	1.8		μs
Time between conversion	t_{CYC}		-55°C to +125°C	01	4.0		μs
Data write/read during conversion	t_{DATA}		-55°C to +125°C	01		1.0	μs
CNV pulse width	t_{CNVH}		-55°C to +125°C	01	10		ns
SCK period	t_{SCK}		-55°C to +125°C	01	t_{DSDO} + 2		ns
SCK low time	t_{SCKL}		-55°C to +125°C	01	11		ns
SCK high time	t_{SCKH}		-55°C to +125°C	01	11		ns
SCK falling edge to data remains valid	t_{HSDO}		-55°C to +125°C	01	4		ns
SCK falling edge to data valid delay	t_{DSDO}	V_{IO} above 2.7 V	-55°C to +125°C	01		18	ns
		V_{IO} above 2.3 V				23	
		V_{IO} above 1.8 V				28	
CNV low to SDO D15 MSB valid	t_{EN}	V_{IO} above 2.7 V	-55°C to +125°C	01		18	ns
		V_{IO} above 2.3 V				22	
		V_{IO} above 1.8 V				25	
CNV high or last SCK falling edge to SDO high impedance	t_{DIS}		-55°C to +125°C	01		32	ns
CNV low to SCK rising edge	t_{CLSCK}		-55°C to +125°C	01	10		ns
DIN valid setup time from SCK rising edge	t_{SDIN}		-55°C to +125°C	01	5		ns
DIN valid hold time from SCK rising edge	t_{HDIN}		-55°C to +125°C	01	5		ns

See footnotes at end of table.

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TABLE I. Electrical performance characteristics – Continued. 1/

- 1/ Testing and other quality control techniques are used to the extent deemed necessary to assure product performance over the specified temperature range. Product may not necessarily be tested across the full temperature range and all parameters may not necessarily be tested. In the absence of specific parametric testing, product performance is assured by characterization and/or design.
- 2/ The bandwidth is set in the configuration register.
- 3/ LSB means least significant bit. With the 5 V input range, one LSB = 305 μ V.
- 4/ These specifications include full temperature range variation but, not the error contribution from the external reference.
- 5/ Unless otherwise specified, $V_{DD} = 5$ V.
- 6/ Unless otherwise specified, all specifications expressed in decibels are referred to a full scale input FSR and tested with an input signal at 0.5 dB below full scale.
- 7/ This is the output from the internal band gap.
- 8/ The output voltage is internal and present on a dedicated multiplexer input.
- 9/ Unipolar mode: serial 14 bit straight binary.
Bipolar mode: serial 14 bit two's complement.
- 10/ Conversion results available immediately after completed conversion.
- 11/ With digital inputs forced to V_{IO} or GND as required.
- 12/ During acquisition phase.

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Case X

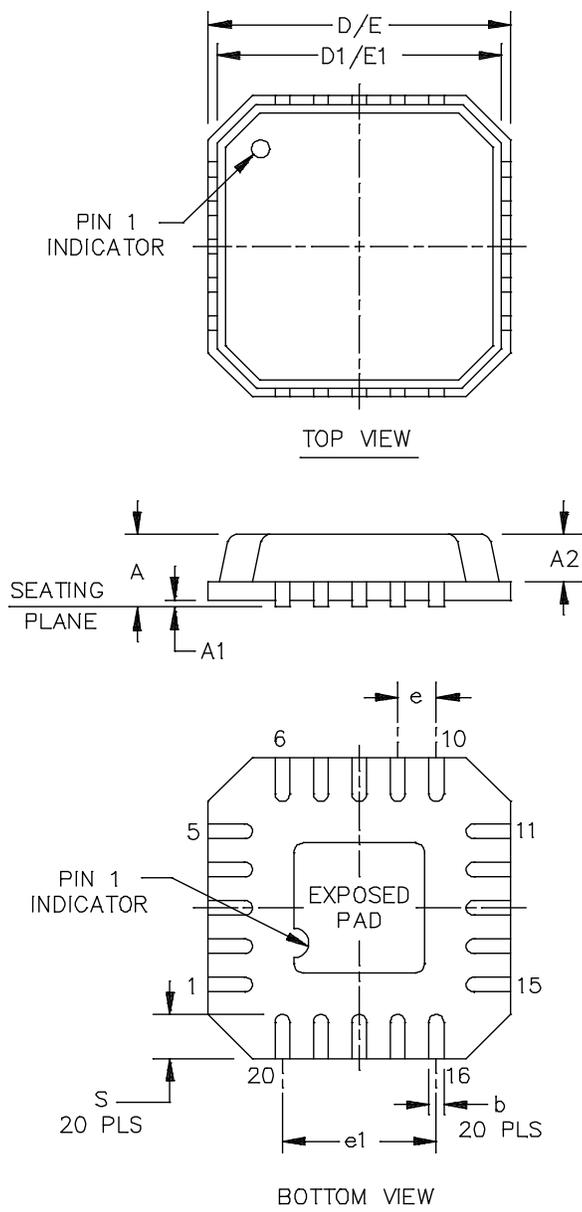


FIGURE 1. Case outline.

<p>DLA LAND AND MARITIME COLUMBUS, OHIO</p>	<p>SIZE A</p>	<p>CODE IDENT NO. 16236</p>	<p>DWG NO. V62/12645</p>
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Case X

Symbol	Dimensions			
	Inches		Millimeters	
	Min	Max	Min	Max
A	.031	.039	0.80	1.00
A1	.0007	.001	0.02	0.05
A2	.025	.031	0.65	0.80
b	.007	.011	0.18	0.30
D/E	.157 BSC		4.00 BSC	
D1/E1	.147 BSC		3.75 BSC	
e	.019 BSC		0.50 BSC	
e1	.092	.104	2.35	2.65
s	.011	.019	0.30	0.50

NOTES:

1. Controlling dimensions are millimeter, inch dimensions are given for reference only.
2. Falls within reference to JEDEC MO-220-VGGD-1.

FIGURE 1. Case outline - Continued.

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Device type	01
Case outline	X
Terminal number	Terminal symbol
1	V _{DD}
2	REF
3	REFIN
4	GND
5	GND
6	IN 4
7	IN 5
8	IN 6
9	IN 7
10	COMM
11	CNV
12	DIN
13	SCK
14	SD0
15	V _{IO}
16	IN 0
17	IN 1
18	IN 2
19	IN 3
20	V _{DD}

NOTE: The exposed pad is not connected internally. For increased reliability of the solder joints, it is recommended that the pad be soldered to the system ground plane.

FIGURE 2. Terminal connections.

DLA LAND AND MARITIME COLUMBUS, OHIO	SIZE A	CODE IDENT NO. 16236	DWG NO. V62/12645
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Terminal symbol	Type	Description
V _{DD}	Power	Power supply. Nominally 2.5 V to 5.5 V when using an external reference and decoupled with 10 μ F and 100 nF capacitors. When using the internal reference for 2.5 V output, the minimum should be 3.0 V. When using the internal reference for 4.096 V output, the minimum should be 4.5 V.
REF	Analog input/output	Reference input/output. When the internal reference is enabled, this pin produces a selectable system reference = 2.5 V or 4.096 V. When the internal reference is disabled and the buffer is enabled, REF produces a buffered version of the voltage present on the REFIN pin (4.096 V maximum), useful when using low cost, low power references. For improved drift performance, connect a precision reference to REF (0.5 V to V _{DD}). For any reference method, this pin needs decoupling with an external 10 μ F capacitor connected as close to REF as possible.
REFIN	Analog input/output	Internal reference output/ reference buffer input. When using the internal reference, the internal unbuffered reference voltage is present and needs decoupling with a 0.1 μ F capacitor. When using the internal reference buffer, apply a source between 0.5 V and 4.096 V that is buffered to the REF pin as described above.
GND	Power	Power supply ground.
IN4 to IN7	Analog input	Channel 4 through channel 7 analog inputs.
COM	Analog input	Common channel input. All input channels; IN[7:0], can be referenced to a common mode point of 0 V or V _{REF} / 2 V.
CNV	Digital input	Convert input. On the rising edge, CNV initiates the conversion. During conversion, if CNV is held high, the busy indicator is enabled.
DIN	Digital input	Data input. This pin is used for writing to the 14 bits configuration register. The configuration register can be written to during and after conversion.
SCK	Digital input	Serial data clock input. This input is used to clock out the data on SDO and clock in data on DIN in an MSB first fashion.
SDO	Digital output	Serial data output. The conversion result is output on this pin, synchronized to SCK. In unipolar modes, conversion results are straight binary; in bipolar modes, conversion results are twos complement.
V _{IO}	Power	Input/output interface digital power. Nominally at the same supply as the host interface (1.8 V, 2.5 V, 3 V, or 5 V).
IN0 to IN3	Analog input	Channel 0 through channel 3 analog inputs.
Exposed pad	No connection	The exposed pad is not connected internally. For increased reliability of the solder joints, it is recommended that the pad be soldered to the system ground plane.

FIGURE 2. Terminal connections - continued.

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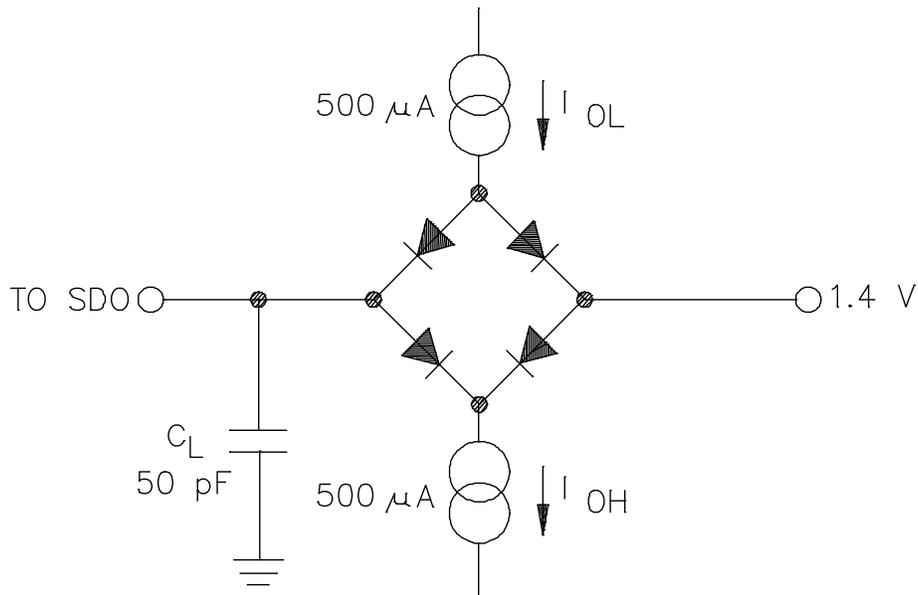
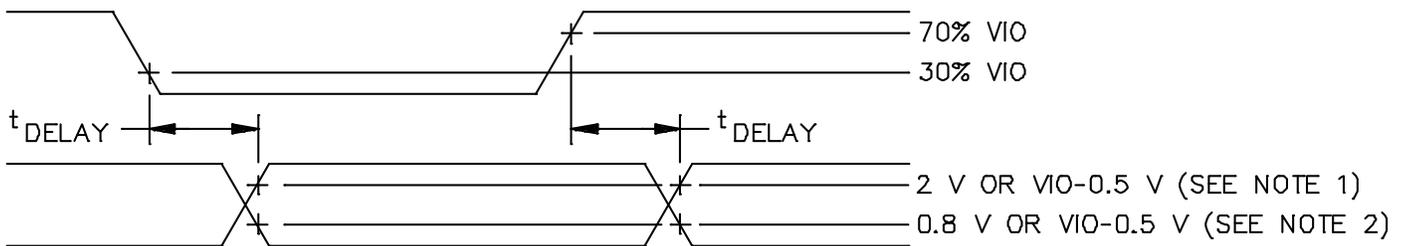


FIGURE 3. Load circuit for digital interface timing.



NOTES:

1. 2 V if V_{IO} above 2.5 V, $V_{IO} - 0.5$ V if V_{IO} below 2.5 V.
2. 0.8 V if V_{IO} above 2.5 V, 0.5 V if V_{IO} below 2.5 V.

FIGURE 4. Voltage levels for timing.

<p align="center">DLA LAND AND MARITIME COLUMBUS, OHIO</p>	<p align="center">SIZE A</p>	<p align="center">CODE IDENT NO. 16236</p>	<p align="center">DWG NO. V62/12645</p>
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4. VERIFICATION

4.1 Product assurance requirements. The manufacturer is responsible for performing all inspection and test requirements as indicated in their internal documentation. Such procedures should include proper handling of electrostatic sensitive devices, classification, packaging, and labeling of moisture sensitive devices, as applicable.

5. PREPARATION FOR DELIVERY

5.1 Packaging. Preservation, packaging, labeling, and marking shall be in accordance with the manufacturer's standard commercial practices for electrostatic discharge sensitive devices.

6. NOTES

6.1 ESDS. Devices are electrostatic discharge sensitive and are classified as ESDS class 1 minimum.

6.2 Configuration control. The data contained herein is based on the salient characteristics of the device manufacturer's data book. The device manufacturer reserves the right to make changes without notice. This drawing will be modified as changes are provided.

6.3 Suggested source(s) of supply. Identification of the suggested source(s) of supply herein is not to be construed as a guarantee of present or continued availability as a source of supply for the item. DLA Land and Maritime maintains an online database of all current sources of supply at <http://www.landandmaritime.dla.mil/Programs/Smcr/>.

Vendor item drawing administrative control number <u>1/</u>	Device manufacturer CAGE code	Vendor part number
V62/12645-01XE	24355	AD7949SCPZ-EP-RL7

1/ The vendor item drawing establishes an administrative control number for identifying the item on the engineering documentation.

CAGE code

24355

Source of supply

Analog Devices
 Route 1 Industrial Park
 P.O. Box 9106
 Norwood, MA 02062
 Point of contact: Raheen Business Park
 Limerick, Ireland

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